

Notice of References Cited		Application/Control No. 10/538,822	Applicant(s)/Patent Under Reexamination LEE ET AL.	
		Examiner STEPHEN YANCHUK	Art Unit 1795	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,063,142	05-2000	Kawakami et al.	29/623.5
*	C	US-2004/0018424	01-2004	Zhang et al.	429/162
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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